

## ESA STUDY CONTRACT REPORT

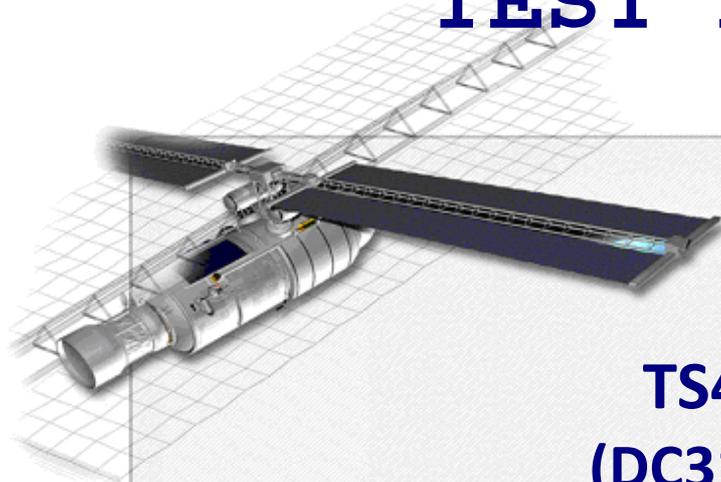
No ESA Study Contract Report will be accepted unless this sheet is inserted at the beginning of each volume of the Report.

ESA Contract No: <b>4000105666/12/NL/SFe</b>	SUBJECT: <b>COO4: Total Ionizing Dose Testing of STMicroelectronics TS4061 Voltage Reference</b>	CONTRACTOR: <b>TRAD</b>
* ESA CR( )No:	No. of Volumes: <b>2</b> This is Volume No: <b>2</b>	CONTRACTOR'S REFERENCE: <b>TRAD/TE/TS4061- HDR/31303A/ESA/FW/1312 Rev1</b>
<b>ABSTRACT:</b> <p>This document is <b>deliverable D3: HDR Test Report</b>, under the Frame Contract 4000105666 with ESA on the Radiation Characterisation of Commercial EEE Components for Space Applications and more specifically on the fourth Call-of-Order for the Total Ionising Dose Testing of ST Microelectronics TS4061 Voltage Reference.</p> <p>This report presents the results from the High Dose Rate (HDR) tests on the TS4061 performed in the SCK-CEN facility at MOL in Belgium. Failures were observed on the Vk and Ikmin parameters at total dose levels above 200 krad. These drifts impacted all the other measured parameters.</p>		
The work described in this report was done under ESA Contract. Responsibility for the contents resides in the author or organisation that prepared it.		
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\* Sections to be completed by ESA

\*\* Information to be provided by ESA Study Manager

# TOTAL IONIZING DOSE TEST REPORT



## TS4061 (DC31303A) Voltage Reference From STMicroelectronics

TRAD/TE/TS4061-HDR/31303A/ESA/FW/1312		Labège, 2 July 2014
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Revision: 0	26/05/2014	
Revision: 1	§3.2, §6.1, §8.2.1 updated	
To: <b>ESA</b> <b>Christian POIVEY</b>	Project/Program: COO4 Ref: ESA Contract 4000105666/12/NL/SFe	

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## 1. INTRODUCTION

This report describes the **High Dose Rate (HDR)** testing and characterization of the **TS4061** manufactured by **STMicroelectronics**. Testing began on 26 February 2014 and ended on 7 March 2014.

## 2. DOCUMENTS

### 2.1. Applicable documents

- Financial and technical proposal: TRAD/P/ESA/COO4/AV/161013 Rev.0
- Irradiation test plan: ITP/TRA/TS4061-HDR/FP10/STM/151013/1 of 20-01-2014
- Mail from G.Chaumont, dated 20/01/2014, subject: "RE: ESA TID tests on TS4061 - need answers"
- Mail from A Varotsou, dated 20/01/2014, subject: "Fwd: Deliverable 1 (D1) COO4: Test Plans LDR and HDR"

### 2.2. Reference documents

- Standard method: MIL-STD-883H method 1019.8 of 26/02/2010
- Datasheet: STMicroelectronics TS4061 rev8 of December 2013

## 3. PART INFORMATION

### 3.1. Identification

<b>Part designation</b>	TS4061
<b>Manufacturer</b>	STMicroelectronics
<b>Part function</b>	Voltage Reference

### 3.2. Procurement information

<b>Package</b>	FP-10
<b>Date code</b>	31303A
<b>Customer P/O</b>	1321
<b>Number of tested parts</b>	10 irradiated samples + 1 reference sample

### 3.3. Sample pictures

#### 3.3.1. External view

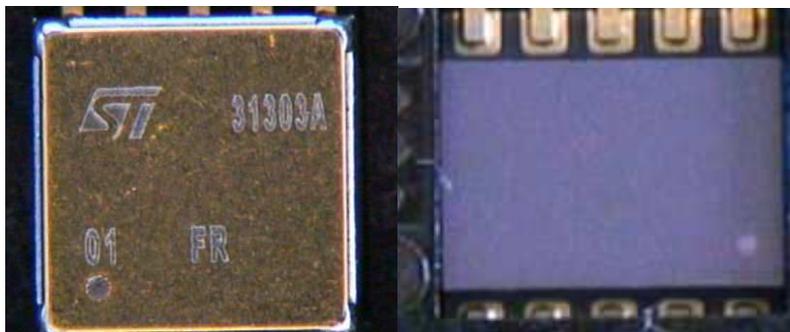


Figure 1: Package marking

#### 3.3.2. Internal view

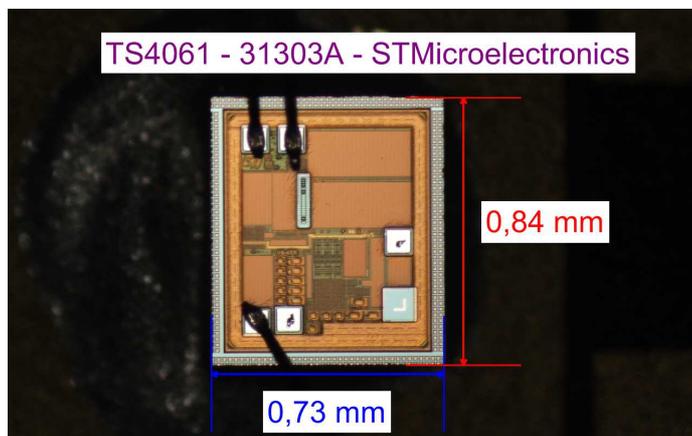


Figure 2: Internal overall view

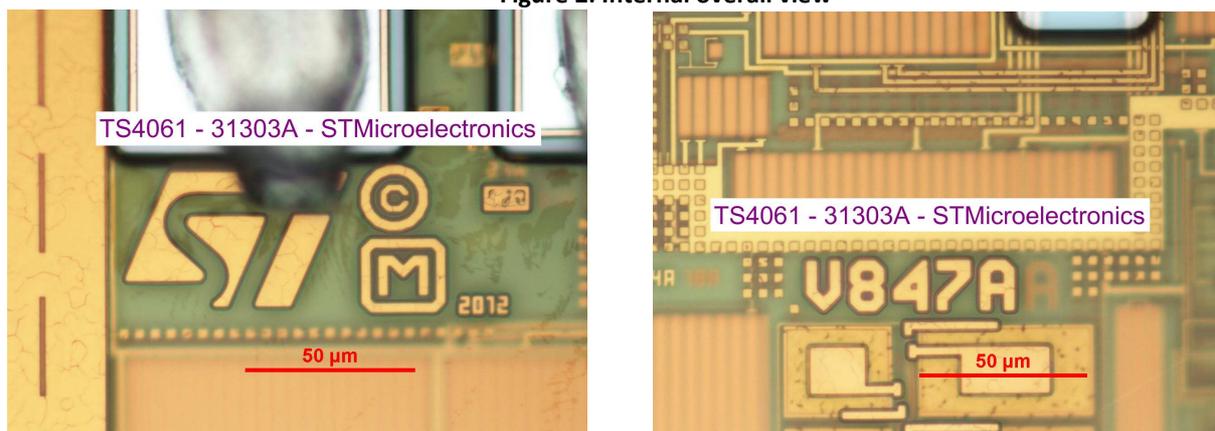


Figure 3: Die marking

## 4. DOSIMETRY AND IRRADIATION FACILITY

### 4.1. Irradiation facility

Irradiation source	$^{60}\text{Co}$
Source location	SCK-CEN (Mol, Belgium)
Irradiation equipment	BR-2

#### 4.1.1. Irradiation facility (SCK-CEN, MOL)

Gamma emitted radiation energies are 1.17 and 1.33 MeV.

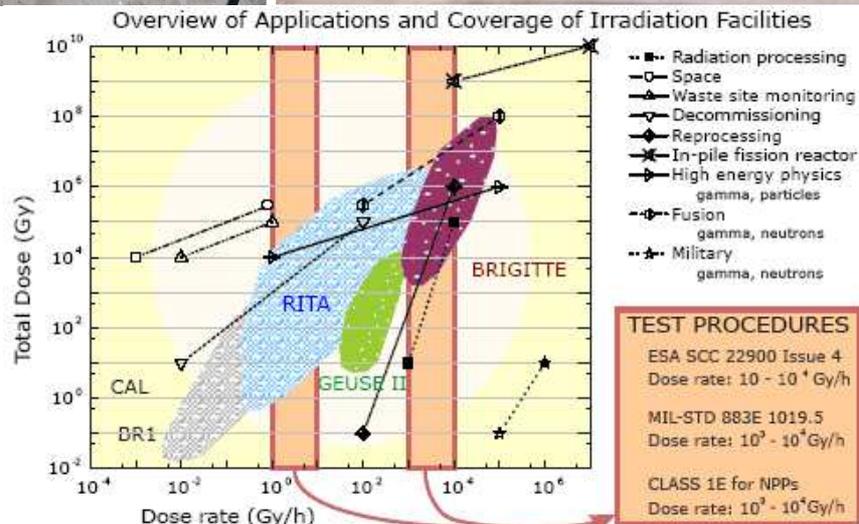


Figure 4 : Irradiation facility

SCKCEN is operating different gamma irradiation facilities, with gamma dose rates ranging from 0.1 Gy/h up to 50 kGy/h. The gamma sources are <sup>60</sup>Co. The gamma facilities cover most of the application areas dealing with ionising radiation.

The 6 different facilities have a wide range of requirements to provide representative, repeatable and reliable tests. These requirements are:

- A rather flexible dose rate from 0.1 Gy/h up to 50 kGy/h
- Reliable dose measurements: the dose rate is measured with Red Perspex (PMMA) or TLD's with accuracy better than 5%
- Atmosphere control: rinsing the samples with dry air, N<sup>2</sup>, CO<sup>2</sup>, etc
- Temperature control: an active temperature control up to 300 °C in several irradiation facilities
- Online measurement and biasing capabilities: standard instrumentation is available and also the possibility to install your own special instrumentation
- Irradiations in a high vacuum atmosphere up to 10<sup>-5</sup> mbar are possible

#### 4.2. Irradiation time log

<b>Total dose limit (krad(Si))</b>	300						
<b>Levels for measurements (krad(Si))</b>	0	25	50	75	100	200	300
<b>Dose rate (krad(Si)/h)</b>	180						

#### 4.3. Annealing time log

<b>Annealing at 25°C</b>	24h
<b>Annealing at 100°C</b>	168h

## 5. BIAS SETUP

All irradiated components are biased under the following conditions. One component is not irradiated to act as a *REFERENCE*. All the parameters specified in the applicable ITP are measured on the *REFERENCE* and irradiated components.

### 5.1. Parts distribution

Serial number	Reference	Samples irradiated									
Mark	22	12	13	14	15	16	17	18	19	20	21
TRAD mark	1	2	3	4	5	6	7	8	9	10	11
Bias mode	REF	ON					OFF				

### 5.2. Bias condition

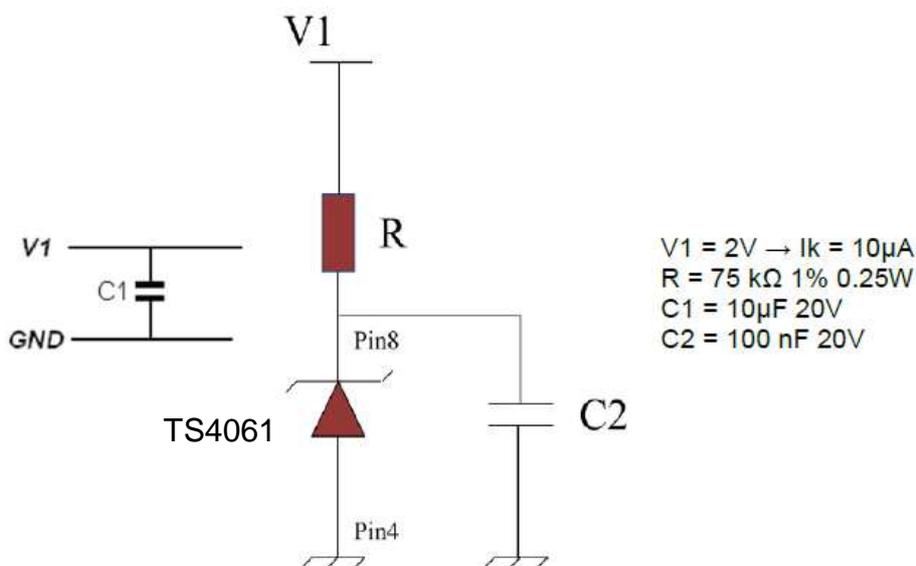


Figure 5 : Bias Condition

### 5.3. Bias equipment identification

Bias board	TRAD/CP1/E/TS4061-HDR/DIL14/FW/1402 TRAD/CP1/5-OF/DIL14/LS/1306
Equipment	GR-04

## 6. TEST SETUP

### 6.1. Test parameters

Parameters	Symbols	Test conditions	Limits**	
			Min	Max
<b>Ta = 25°C, unless otherwise specified</b>				
Reverse Breakdown Voltage	Vk	Ik = 10µA	1.2487V	1.2512V
Minimum Operating Current	Ikmin	Vk = 1.25V	-	10µA
Average Temperature Coefficient	DVk/DT*	Ik= 10µA	-	35ppm/°C
		Ik= 15mA		
Average Reverse Breakdown Voltage vs Operating Current Range	DVk1/Ik	10µA ≤ Ik ≤ 1mA	-	1mV
	DVk2/Ik	1mA ≤ Ik ≤ 15mA	-	4mV
Static Impedance	Rka	DIk = 10µA to 10 mA	-	0.3Ω
Wide Band Noise	en	Ik = 10 µA et f = 1 kHz	-	-

\*For Average Temperature Coefficient calculation, Vk shall be measured at -55°C, -15°C, 25°C, 75°C and 125°C. This measurement shall only be calculated before irradiation, and after the last irradiation step, and after each annealing step. The formula used to calculate this coefficient is  $\frac{V_{kmax} - V_{kmin}}{180^{\circ}C \times V_{k(25^{\circ}C)}} \times 10^6$ .

\*\* These limits are based on the Datasheet: STMicroelectronics TS4061 rev8 of December 2013. Since the chips tested have been packaged in a package not qualified by STM, limits are given for indication only.

### 6.2. Test equipment identification

<b>Test board</b>	TRAD/CT1/E/TS4061-HDR/31303A/ESA/FW/1402 TRAD/CT3/E/RHF1009A-LDR/XXX1/STM/APD/1301
<b>Equipment</b>	MI-59 ; SM-82 ; GR-53 ; MI-16
<b>Test program</b>	TS4061-HDR_B2_dev_v10.llb TS4061-HDR_B2_dev_v20.llb TS4061-HDR_B2_dev_v30.llb

## 7. NON CONFORMANCE

Test and measurement conditions were nominal.

## 8. RESULTS

### 8.1. Presentation of the results

For each parameter:

- The measurements performed at each irradiation step are registered in a table.
- Drifts between each measurement step and the "0" krad(Si) step are computed.

### 8.2. Drift of the parameters

#### 8.2.1. Parts biased ON

The parameter  $V_k$  shows a drift at 200 kRad. The current  $I_k$  set at  $10\mu\text{A}$ , as specified in the datasheet, does not allow the device to saturate properly.

This behaviour is confirmed on the  $I_{kmin}$  parameter (p. A-3 of the Appendix). The latter is not measurable at the 200 and 300 kRad steps. To perform the  $I_{kmin}$  measurement, the  $I_k$  current is increased until the output voltage  $V_k = 1.25\text{V}$  is obtained. In our case, at the 200 and 300 kRad steps, the output voltage  $V_k$  can not be reached in spite of the fact that the current was increased drastically (up to  $15\text{mA}$ ).

Parameters  $\frac{DV_{K2}}{DT}$ ,  $\frac{DV_{K1}}{DI_k}$  and  $\frac{DV_{K2}}{DI_k}$  were also impacted by the drift of  $I_k$ .

After annealing, the  $I_{kmin}$  parameter does not recover completely. However, even if the current is high for several parts all parameters are measurable.

#### 8.2.2. Parts biased OFF

Parts biased OFF are less sensitive than parts biased ON. The degradation of the  $V_k$  parameter is less important at the 200 kRad and 300 kRad steps than the degradation observed on parts biased ON.

This tendency is confirmed on the  $I_k$  parameter, which is still measurable at 200 kRad in spite of the important rise of the current. At the 300 kRad step,  $V_k = 1.25\text{V}$  can not be reached in spite of the  $I_k$  current important increase (up to  $15\text{mA}$ ).

## 9. CONCLUSION

The total dose steady-state irradiation test using gamma rays from Cobalt 60 source has been carried out on **10 TS4061**, a **Voltage Reference** from **STMicroelectronics** up to **300 krad(Si)** at high dose rate ( $180\text{ krad(Si)/h}$ ).

Failures were observed on the  $V_k$  and  $I_k$  parameters at total dose level above 200 krad. These drifts impacted all the other parameters measured. After the annealing steps, all the parameters are measurable.

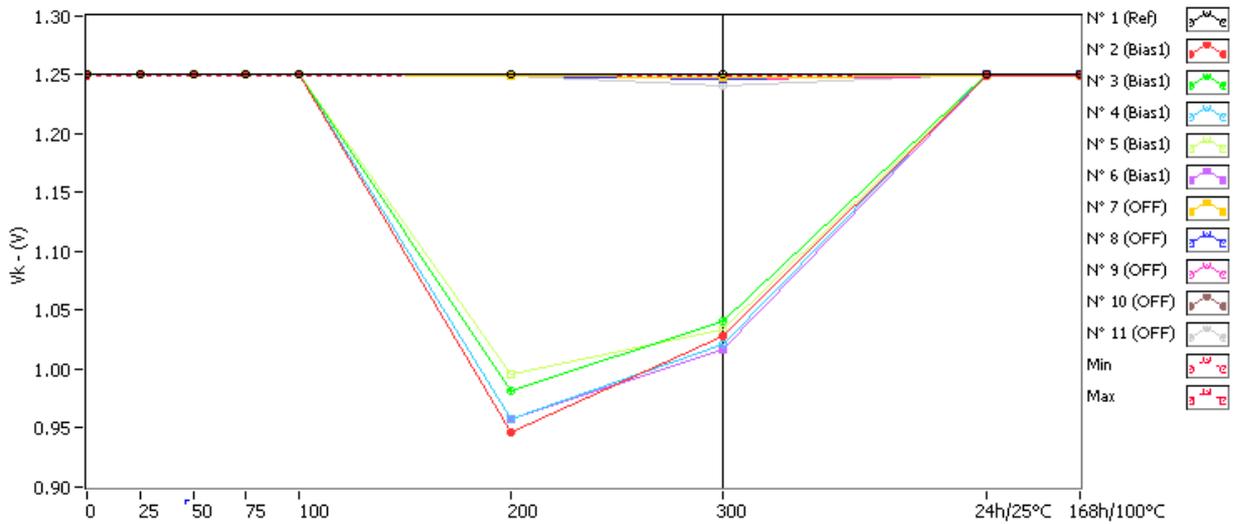
## **10. APPENDIX 1 MEASURED PARAMETERS**

**Contents :**

1	Vk	.....	A-2
2	Ikmin	.....	A-3
3	DVk1/DT	.....	A-4
4	DVk2/DT	.....	A-5
5	DVk1/Ik	.....	A-6
6	DVk2/Ik	.....	A-7
7	Rka	.....	A-8
8	en	.....	A-9

# 1. Vk

Ta=25°C ; Ik=10µA



Vk . (V) Min = 1.2487 Max = 1.2512

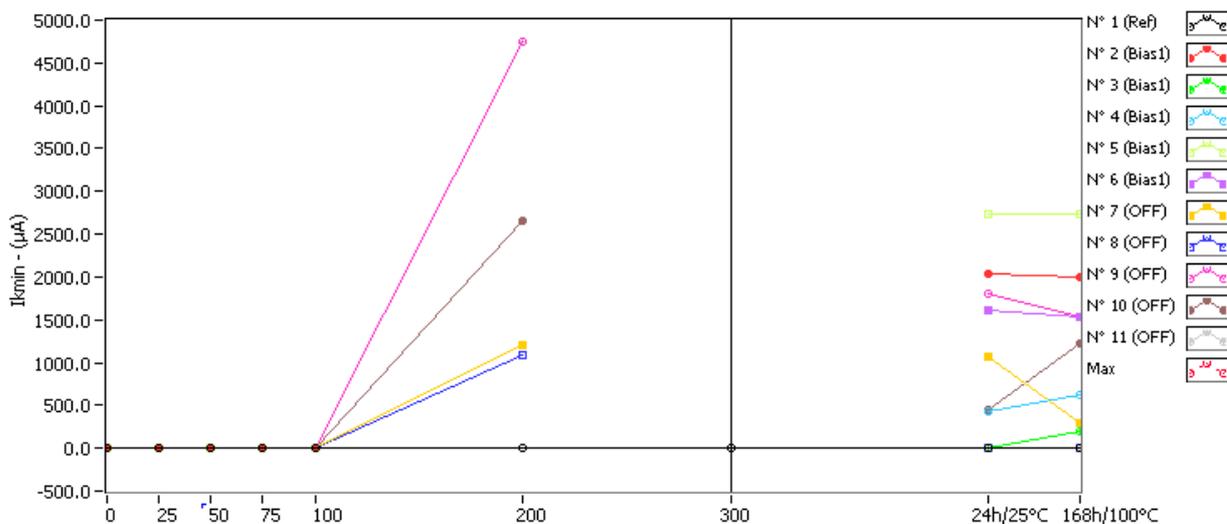
	0krad(Si)	25krad(Si)	50krad(Si)	75krad(Si)	100krad(Si)	200krad(Si)	300krad(Si)	24h/25°C	168h/100°C
N° 1 (Ref)	1.2506	1.2505	1.2505	1.2505	1.2505	1.2505	1.2505	1.2506	1.2506
N° 2 (Bias1)	1.2505	1.2503	1.2503	1.2503	1.2500	0.9465	1.0280	1.2496	1.2495
N° 3 (Bias1)	1.2510	1.2508	1.2508	1.2507	1.2504	0.9823	1.0402	1.2501	1.2499
N° 4 (Bias1)	1.2511	1.2510	1.2509	1.2508	1.2506	0.9579	1.0216	1.2500	1.2498
N° 5 (Bias1)	1.2506	1.2505	1.2504	1.2503	1.2501	0.9951	1.0340	1.2494	1.2493
N° 6 (Bias1)	1.2510	1.2509	1.2509	1.2508	1.2506	0.9582	1.0174	1.2498	1.2496
N° 7 (OFF)	1.2505	1.2504	1.2504	1.2504	1.2503	1.2497	1.2478	1.2497	1.2499
N° 8 (OFF)	1.2509	1.2509	1.2510	1.2509	1.2508	1.2499	1.2471	1.2503	1.2503
N° 9 (OFF)	1.2504	1.2504	1.2504	1.2504	1.2502	1.2490	1.2459	1.2495	1.2496
N° 10 (OFF)	1.2504	1.2504	1.2504	1.2503	1.2503	1.2495	1.2465	1.2499	1.2496
N° 11 (OFF)	1.2509	1.2508	1.2509	1.2508	1.2508	1.2492	1.2409	1.2503	1.2502

Delta [Vk]

	0krad(Si)	25krad(Si)	50krad(Si)	75krad(Si)	100krad(Si)	200krad(Si)	300krad(Si)	24h/25°C	168h/100°C
N° 1 (Ref)	---	-1.600E-5	-1.500E-5	-1.800E-5	-1.700E-5	-1.600E-5	-1.700E-5	1.000E-6	1.000E-6
N° 2 (Bias1)	---	-1.510E-4	-1.550E-4	-1.900E-4	-4.440E-4	-3.040E-1	-2.225E-1	-8.770E-4	-1.028E-3
N° 3 (Bias1)	---	-1.960E-4	-2.200E-4	-2.640E-4	-5.590E-4	-2.687E-1	-2.108E-1	-8.390E-4	-1.093E-3
N° 4 (Bias1)	---	-1.330E-4	-1.790E-4	-2.340E-4	-4.660E-4	-2.932E-1	-2.295E-1	-1.082E-3	-1.286E-3
N° 5 (Bias1)	---	-1.930E-4	-2.260E-4	-3.750E-4	-5.100E-4	-2.555E-1	-2.166E-1	-1.254E-3	-1.378E-3
N° 6 (Bias1)	---	-1.450E-4	-1.190E-4	-2.130E-4	-4.550E-4	-2.928E-1	-2.336E-1	-1.165E-3	-1.438E-3
N° 7 (OFF)	---	-8.100E-5	-7.500E-5	-8.000E-5	-1.520E-4	-7.800E-4	-2.706E-3	-7.580E-4	-5.990E-4
N° 8 (OFF)	---	-7.300E-5	3.000E-6	-1.100E-5	-1.190E-4	-1.055E-3	-3.886E-3	-6.780E-4	-6.950E-4
N° 9 (OFF)	---	-3.000E-5	2.600E-5	-2.400E-5	-1.630E-4	-1.373E-3	-4.500E-3	-8.850E-4	-8.320E-4
N° 10 (OFF)	---	-6.300E-5	-1.700E-5	-7.400E-5	-1.290E-4	-9.320E-4	-3.912E-3	-5.300E-4	-7.710E-4
N° 11 (OFF)	---	-5.000E-5	-2.300E-5	-5.800E-5	-1.120E-4	-1.646E-3	-9.952E-3	-5.830E-4	-6.780E-4
Average (OFF)	---	-1.636E-4	-1.798E-4	-2.552E-4	-4.868E-4	-2.828E-1	-2.226E-1	-1.043E-3	-1.245E-3
s (OFF)	---	2.896E-5	4.490E-5	7.230E-5	4.750E-5	2.000E-2	9.256E-3	1.803E-4	1.781E-4
Average+3s (OFF)	---	-7.671E-5	-4.511E-5	-3.829E-5	-3.443E-4	-2.228E-1	-1.948E-1	-5.024E-4	-7.104E-4
Average-3s (OFF)	---	-2.505E-4	-3.145E-4	-4.721E-4	-6.293E-4	-3.428E-1	-2.504E-1	-1.584E-3	-1.779E-3
Average (Bias1)	---	-5.940E-5	-1.720E-5	-4.940E-5	-1.350E-4	-1.157E-3	-4.991E-3	-6.868E-4	-7.150E-4
s (Bias1)	---	2.011E-5	3.758E-5	3.056E-5	2.176E-5	3.496E-4	2.849E-3	1.412E-4	8.951E-5
Average+3s (Bias1)	---	9.216E-7	9.554E-5	4.227E-5	-6.972E-5	-1.083E-4	3.555E-3	-2.631E-4	-4.465E-4
Average-3s (Bias1)	---	-1.197E-4	-1.299E-4	-1.411E-4	-2.003E-4	-2.206E-3	-1.354E-2	-1.111E-3	-9.835E-4

## 2. Ikmin

Ta=25°C ; Vk=1.25V



Ikmin . (µA) Max = 10.0

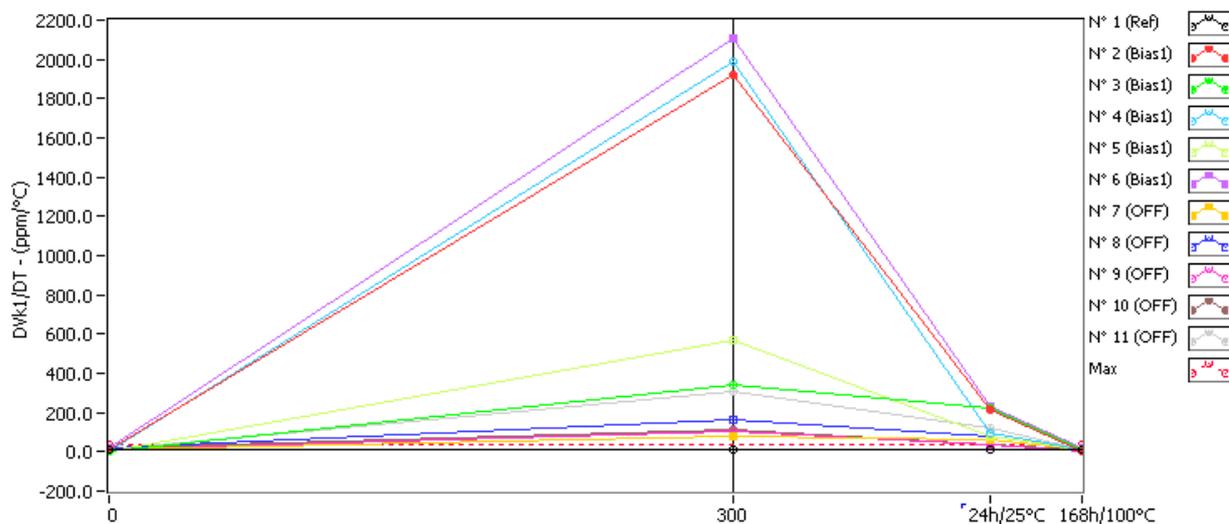
	0krad(Si)	25krad(Si)	50krad(Si)	75krad(Si)	100krad(Si)	200krad(Si)	300krad(Si)	24h/25°C	168h/100°C
N° 1 (Ref)	7.020	7.040	7.040	7.060	7.040	7.050	7.050	7.020	7.000
N° 2 (Bias1)	6.970	6.960	7.000	7.720	9.850	Not Measurable	Not Measurable	2035.000	2005.000
N° 3 (Bias1)	6.920	6.910	6.980	8.150	9.610	Not Measurable	Not Measurable	7.880	200.390
N° 4 (Bias1)	7.010	6.970	7.040	7.920	9.330	Not Measurable	Not Measurable	437.690	631.500
N° 5 (Bias1)	6.960	6.940	7.070	8.650	9.800	Not Measurable	Not Measurable	2728.000	2726.500
N° 6 (Bias1)	6.990	6.980	7.050	7.920	9.300	Not Measurable	Not Measurable	1610.000	1542.500
N° 7 (OFF)	7.010	7.000	7.000	7.000	7.010	1200.000	Not Measurable	1059.890	302.500
N° 8 (OFF)	6.990	7.000	7.000	7.000	7.010	1089.000	Not Measurable	7.040	6.500
N° 9 (OFF)	6.960	6.970	6.960	6.970	7.010	4750.000	Not Measurable	1809.000	1536.500
N° 10 (OFF)	7.070	7.070	7.080	7.080	7.090	2650.000	Not Measurable	446.890	1215.500
N° 11 (OFF)	6.980	6.980	6.990	6.980	6.990	4750.000	Not Measurable	7.010	6.950

Delta [Ikmin]

	0krad(Si)	25krad(Si)	50krad(Si)	75krad(Si)	100krad(Si)	200krad(Si)	300krad(Si)	24h/25°C	168h/100°C
N° 1 (Ref)	---	2.000E-2	2.000E-2	4.000E-2	2.000E-2	3.000E-2	3.000E-2	0.000E+0	-2.000E-2
N° 2 (Bias1)	---	-1.000E-2	3.000E-2	7.500E-1	2.880E+0	NaN	NaN	2.028E+3	1.998E+3
N° 3 (Bias1)	---	-1.000E-2	6.000E-2	1.230E+0	2.690E+0	NaN	NaN	9.600E-1	1.935E+2
N° 4 (Bias1)	---	-4.000E-2	3.000E-2	9.100E-1	2.320E+0	NaN	NaN	4.307E+2	6.245E+2
N° 5 (Bias1)	---	-2.000E-2	1.100E-1	1.690E+0	2.840E+0	NaN	NaN	2.721E+3	2.720E+3
N° 6 (Bias1)	---	-1.000E-2	6.000E-2	9.300E-1	2.310E+0	NaN	NaN	1.603E+3	1.536E+3
N° 7 (OFF)	---	-1.000E-2	-1.000E-2	-1.000E-2	0.000E+0	1.193E+3	NaN	1.053E+3	2.955E+2
N° 8 (OFF)	---	1.000E-2	1.000E-2	1.000E-2	2.000E-2	1.082E+3	NaN	5.000E-2	-4.900E-1
N° 9 (OFF)	---	1.000E-2	0.000E+0	1.000E-2	5.000E-2	4.743E+3	NaN	1.802E+3	1.530E+3
N° 10 (OFF)	---	0.000E+0	1.000E-2	1.000E-2	2.000E-2	2.643E+3	NaN	4.398E+2	1.208E+3
N° 11 (OFF)	---	0.000E+0	1.000E-2	0.000E+0	1.000E-2	4.743E+3	NaN	3.000E-2	-3.000E-2
Average (OFF)	---	-1.800E-2	5.800E-2	1.102E+0	2.608E+0	NaN	NaN	1.357E+3	1.414E+3
s (OFF)	---	1.304E-2	3.271E-2	3.716E-1	2.767E-1	0.000E+0	0.000E+0	1.126E+3	1.021E+3
Average+3s (OFF)	---	2.112E-2	1.561E-1	2.217E+0	3.438E+0	NaN	NaN	4.734E+3	4.479E+3
Average-3s (OFF)	---	-5.712E-2	-4.013E-2	-1.293E-2	1.778E+0	NaN	NaN	-2.020E+3	-1.650E+3
Average (Bias1)	---	2.000E-3	4.000E-3	4.000E-3	2.000E-2	2.881E+3	NaN	6.590E+2	6.066E+2
s (Bias1)	---	8.367E-3	8.944E-3	8.944E-3	1.871E-2	1.808E+3	0.000E+0	7.711E+2	7.154E+2
Average+3s (Bias1)	---	2.710E-2	3.083E-2	3.083E-2	7.612E-2	8.305E+3	NaN	2.972E+3	2.753E+3
Average-3s (Bias1)	---	-2.310E-2	-2.283E-2	-2.283E-2	-3.612E-2	-2.543E+3	NaN	-1.654E+3	-1.540E+3

### 3. DVk1/DT

DT=-55°C to 125°C ; Ik = 10µA



DVk1/DT . (ppm/°C)

Max = 35.0

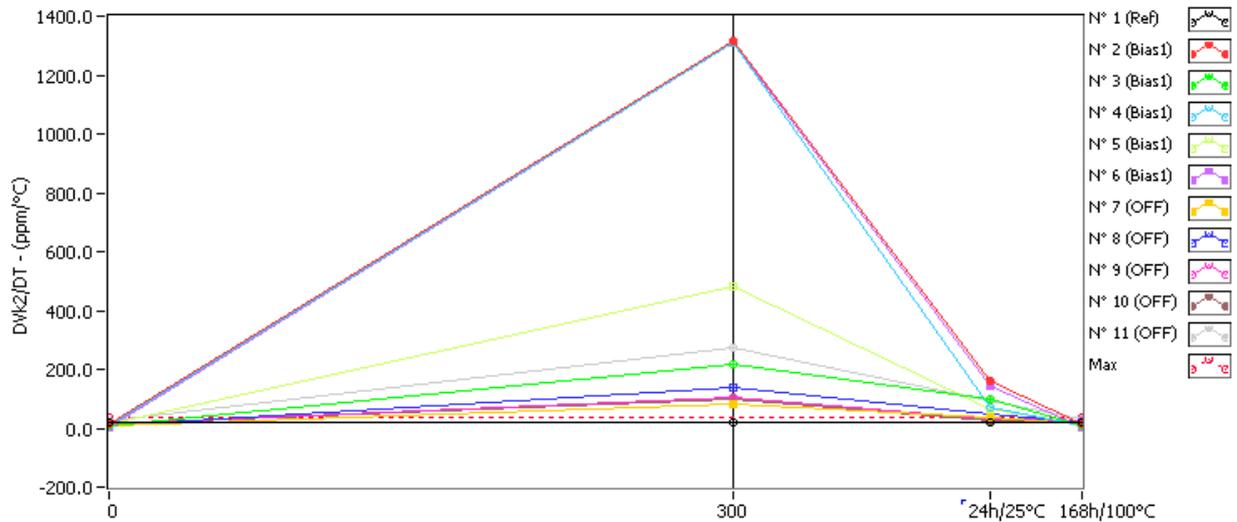
	0krad(Si)	300krad(Si)	24h/25°C	168h/100°C
N° 1 (Ref)	7.39	8.25	9.46	9.28
N° 2 (Bias1)	7.88	1924.09	215.46	6.10
N° 3 (Bias1)	5.91	338.20	224.19	14.86
N° 4 (Bias1)	3.47	1992.55	99.96	9.99
N° 5 (Bias1)	5.05	567.82	80.46	11.18
N° 6 (Bias1)	22.01	2105.21	229.08	21.82
N° 7 (OFF)	10.19	82.43	65.97	10.87
N° 8 (OFF)	18.02	160.26	82.79	8.16
N° 9 (OFF)	11.61	101.89	39.34	6.51
N° 10 (OFF)	18.20	110.67	40.30	10.76
N° 11 (OFF)	12.04	311.08	125.15	12.17

Delta [DVk1/DT]

	0krad(Si)	300krad(Si)	24h/25°C	168h/100°C
N° 1 (Ref)	---	8.544E-1	2.069E+0	1.888E+0
N° 2 (Bias1)	---	1.916E+3	2.076E+2	-1.779E+0
N° 3 (Bias1)	---	3.323E+2	2.183E+2	8.950E+0
N° 4 (Bias1)	---	1.989E+3	9.648E+1	6.516E+0
N° 5 (Bias1)	---	5.628E+2	7.541E+1	6.134E+0
N° 6 (Bias1)	---	2.083E+3	2.071E+2	-1.860E-1
N° 7 (OFF)	---	7.224E+1	5.578E+1	6.827E-1
N° 8 (OFF)	---	1.422E+2	6.476E+1	-9.861E+0
N° 9 (OFF)	---	9.027E+1	2.773E+1	-5.102E+0
N° 10 (OFF)	---	9.246E+1	2.210E+1	-7.447E+0
N° 11 (OFF)	---	2.990E+2	1.131E+2	1.254E-1
Average (OFF)	---	1.377E+3	1.610E+2	3.927E+0
s (OFF)	---	8.542E+2	6.903E+1	4.644E+0
Average+3s (OFF)	---	3.939E+3	3.681E+2	1.786E+1
Average-3s (OFF)	---	-1.186E+3	-4.613E+1	-1.001E+1
Average (Bias1)	---	1.393E+2	5.670E+1	-4.320E+0
s (Bias1)	---	9.303E+1	3.635E+1	4.634E+0
Average+3s (Bias1)	---	4.183E+2	1.657E+2	9.581E+0
Average-3s (Bias1)	---	-1.398E+2	-5.234E+1	-1.822E+1

## 4. DVk2/DT

DT=-55°C to 125°C ; Ik = 15mA



DVk2/DT . (ppm/°C)

Max = 35.0

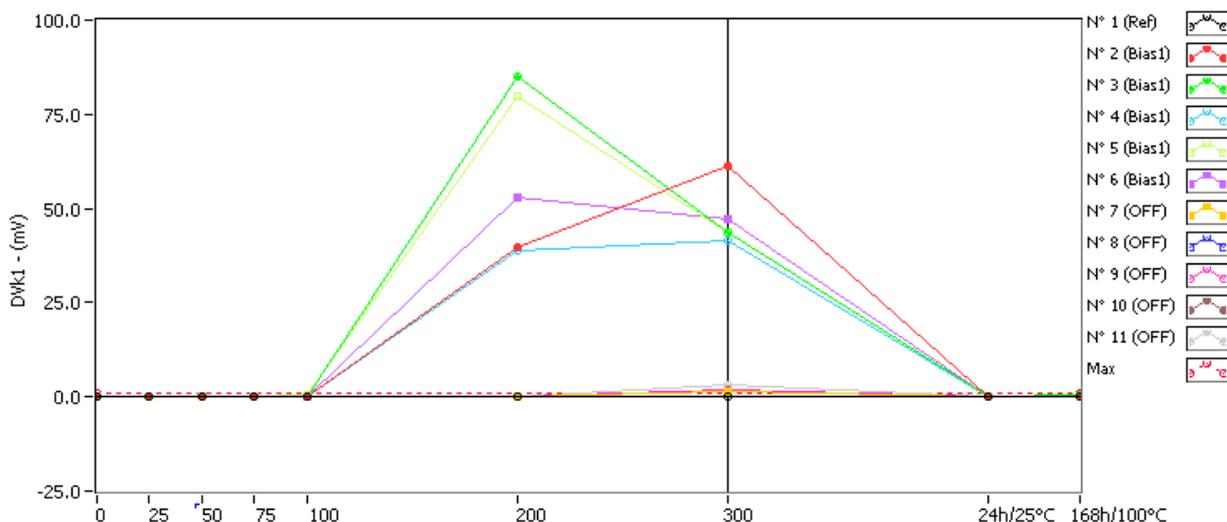
	0krad(Si)	300krad(Si)	24h/25°C	168h/100°C
N° 1 (Ref)	17.81	18.26	18.96	19.81
N° 2 (Bias1)	13.98	1317.73	161.33	11.63
N° 3 (Bias1)	8.26	216.51	99.14	7.88
N° 4 (Bias1)	10.78	1312.57	72.38	10.47
N° 5 (Bias1)	13.36	484.20	66.51	13.42
N° 6 (Bias1)	5.55	1311.62	140.98	4.11
N° 7 (OFF)	6.72	79.42	38.88	14.56
N° 8 (OFF)	11.07	139.84	47.49	18.87
N° 9 (OFF)	16.32	102.60	32.17	23.95
N° 10 (OFF)	12.73	96.61	25.14	21.64
N° 11 (OFF)	22.77	274.39	91.66	28.43

Delta [DVk2/DT]

	0krad(Si)	300krad(Si)	24h/25°C	168h/100°C
N° 1 (Ref)	---	4.518E-1	1.155E+0	2.000E+0
N° 2 (Bias1)	---	1.304E+3	1.473E+2	-2.354E+0
N° 3 (Bias1)	---	2.083E+2	9.087E+1	-3.807E-1
N° 4 (Bias1)	---	1.302E+3	6.159E+1	-3.101E-1
N° 5 (Bias1)	---	4.708E+2	5.316E+1	5.684E-2
N° 6 (Bias1)	---	1.306E+3	1.354E+2	-1.441E+0
N° 7 (OFF)	---	7.271E+1	3.216E+1	7.847E+0
N° 8 (OFF)	---	1.288E+2	3.642E+1	7.807E+0
N° 9 (OFF)	---	8.628E+1	1.585E+1	7.624E+0
N° 10 (OFF)	---	8.388E+1	1.242E+1	8.911E+0
N° 11 (OFF)	---	2.516E+2	6.889E+1	5.661E+0
Average (OFF)	---	9.181E+2	9.768E+1	-8.859E-1
s (OFF)	---	5.363E+2	4.249E+1	9.925E-1
Average+3s (OFF)	---	2.527E+3	2.252E+2	2.092E+0
Average-3s (OFF)	---	-6.907E+2	-2.980E+1	-3.863E+0
Average (Bias1)	---	1.247E+2	3.315E+1	7.570E+0
s (Bias1)	---	7.411E+1	2.246E+1	1.181E+0
Average+3s (Bias1)	---	3.470E+2	1.005E+2	1.111E+1
Average-3s (Bias1)	---	-9.769E+1	-3.424E+1	4.028E+0

## 5. DVk1

Ta=25°C ; 10µA < Ik < 1mA



DV<sub>k1</sub> . (mV) Max = 1.0

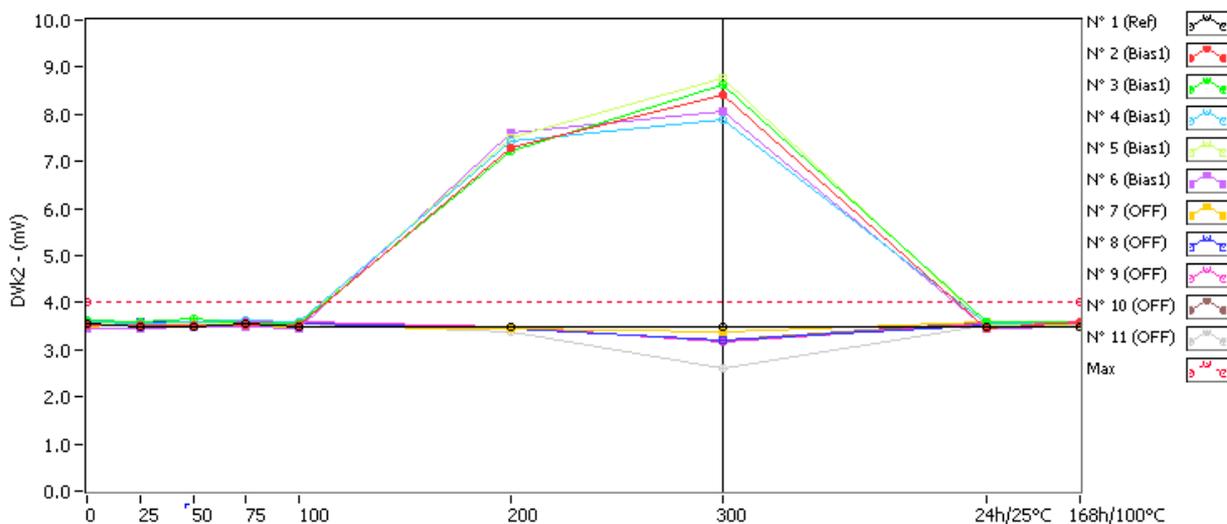
	0krad(Si)	25krad(Si)	50krad(Si)	75krad(Si)	100krad(Si)	200krad(Si)	300krad(Si)	24h/25°C	168h/100°C
N° 1 (Ref)	0.276	0.280	0.279	0.274	0.281	0.276	0.277	0.282	0.280
N° 2 (Bias1)	0.285	0.282	0.287	0.293	0.295	39.752	61.151	0.151	0.286
N° 3 (Bias1)	0.290	0.288	0.303	0.282	0.290	85.154	43.782	0.208	0.330
N° 4 (Bias1)	0.291	0.286	0.295	0.291	0.308	38.914	41.615	0.174	0.307
N° 5 (Bias1)	0.292	0.281	0.283	0.293	0.326	79.627	43.638	0.200	0.300
N° 6 (Bias1)	0.278	0.276	0.277	0.276	0.305	53.091	47.144	0.039	0.293
N° 7 (OFF)	0.279	0.291	0.307	0.306	0.289	0.239	1.358	0.265	0.287
N° 8 (OFF)	0.282	0.293	0.293	0.300	0.285	0.120	1.442	0.238	0.307
N° 9 (OFF)	0.280	0.285	0.288	0.293	0.284	0.088	1.705	0.300	0.309
N° 10 (OFF)	0.278	0.280	0.293	0.290	0.287	0.125	1.195	0.264	0.306
N° 11 (OFF)	0.280	0.283	0.287	0.294	0.295	0.105	3.257	0.262	0.298

Delta [DV<sub>k1</sub>]

	0krad(Si)	25krad(Si)	50krad(Si)	75krad(Si)	100krad(Si)	200krad(Si)	300krad(Si)	24h/25°C	168h/100°C
N° 1 (Ref)	---	3.900E-3	3.160E-3	-1.710E-3	5.460E-3	6.800E-4	9.200E-4	6.660E-3	3.790E-3
N° 2 (Bias1)	---	-3.810E-3	1.970E-3	8.020E-3	9.440E-3	3.947E+1	6.087E+1	-1.344E-1	1.120E-3
N° 3 (Bias1)	---	-1.700E-3	1.286E-2	-8.230E-3	1.000E-5	8.486E+1	4.349E+1	-8.168E-2	4.002E-2
N° 4 (Bias1)	---	-4.680E-3	4.510E-3	4.400E-4	1.715E-2	3.862E+1	4.132E+1	-1.166E-1	1.645E-2
N° 5 (Bias1)	---	-1.057E-2	-9.400E-3	1.080E-3	3.440E-2	7.934E+1	4.335E+1	-9.225E-2	7.760E-3
N° 6 (Bias1)	---	-2.240E-3	-1.610E-3	-2.330E-3	2.686E-2	5.281E+1	4.687E+1	-2.391E-1	1.441E-2
N° 7 (OFF)	---	1.205E-2	2.895E-2	2.748E-2	1.035E-2	-3.962E-2	1.079E+0	-1.318E-2	8.260E-3
N° 8 (OFF)	---	1.130E-2	1.126E-2	1.739E-2	2.680E-3	-1.620E-1	1.160E+0	-4.431E-2	2.470E-2
N° 9 (OFF)	---	5.130E-3	8.310E-3	1.379E-2	4.130E-3	-1.916E-1	1.426E+0	2.048E-2	2.989E-2
N° 10 (OFF)	---	2.950E-3	1.523E-2	1.222E-2	9.300E-3	-1.528E-1	9.176E-1	-1.309E-2	2.859E-2
N° 11 (OFF)	---	3.390E-3	7.770E-3	1.432E-2	1.589E-2	-1.744E-1	2.977E+0	-1.737E-2	1.818E-2
Average (OFF)	---	-4.600E-3	1.666E-3	-2.040E-4	1.757E-2	5.902E+1	4.718E+1	-1.328E-1	1.595E-2
s (OFF)	---	3.544E-3	8.165E-3	5.887E-3	1.364E-2	2.189E+1	7.906E+0	6.288E-2	1.474E-2
Average+3s (OFF)	---	6.033E-3	2.616E-2	1.746E-2	5.849E-2	1.247E+2	7.090E+1	5.585E-2	6.017E-2
Average-3s (OFF)	---	-1.523E-2	-2.283E-2	-1.787E-2	-2.335E-2	-6.664E+0	2.346E+1	-3.214E-1	-2.827E-2
Average (Bias1)	---	6.964E-3	1.430E-2	1.704E-2	8.470E-3	-1.441E-1	1.512E+0	-1.349E-2	2.192E-2
s (Bias1)	---	4.385E-3	8.707E-3	6.130E-3	5.283E-3	6.018E-2	8.395E-1	2.302E-2	8.893E-3
Average+3s (Bias1)	---	2.012E-2	4.043E-2	3.543E-2	2.432E-2	3.647E-2	4.031E+0	5.556E-2	4.860E-2
Average-3s (Bias1)	---	-6.191E-3	-1.182E-2	-1.350E-3	-7.379E-3	-3.246E-1	-1.007E+0	-8.255E-2	-4.754E-3

## 6. DVk2

Ta=25°C ; 1mA < I<sub>k</sub> < 15mA



DV<sub>k2</sub> . (mV) Max = 4.0

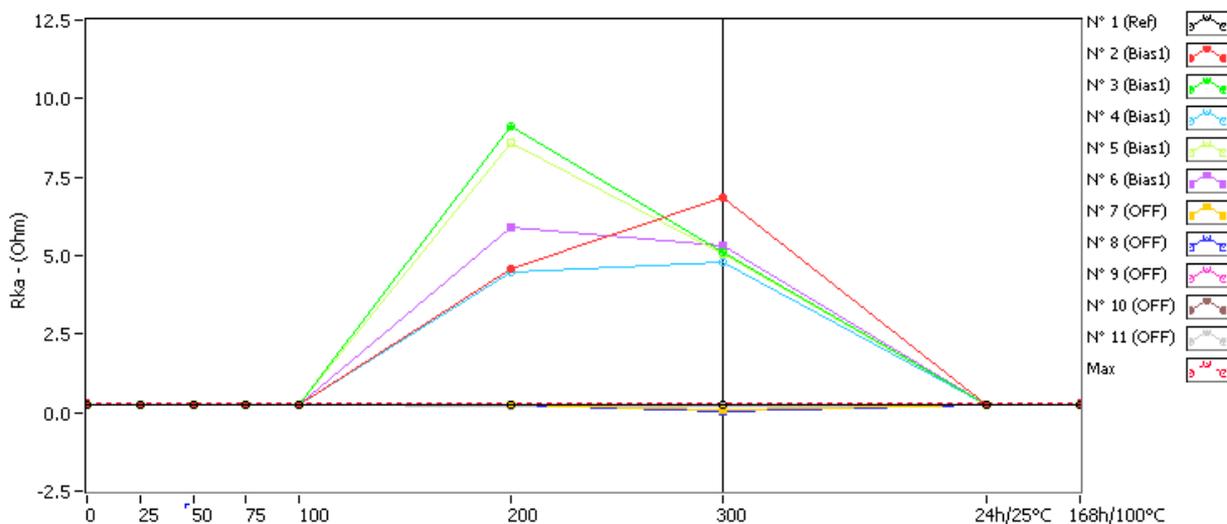
	0krad(Si)	25krad(Si)	50krad(Si)	75krad(Si)	100krad(Si)	200krad(Si)	300krad(Si)	24h/25°C	168h/100°C
N° 1 (Ref)	3.541	3.499	3.500	3.544	3.495	3.487	3.497	3.479	3.472
N° 2 (Bias1)	3.507	3.537	3.527	3.515	3.530	7.272	8.430	3.443	3.580
N° 3 (Bias1)	3.612	3.597	3.644	3.569	3.543	7.223	8.641	3.593	3.596
N° 4 (Bias1)	3.593	3.568	3.595	3.613	3.603	7.422	7.876	3.572	3.600
N° 5 (Bias1)	3.541	3.538	3.566	3.551	3.565	7.505	8.764	3.530	3.522
N° 6 (Bias1)	3.453	3.442	3.497	3.481	3.453	7.589	8.047	3.435	3.474
N° 7 (OFF)	3.482	3.550	3.509	3.496	3.497	3.460	3.372	3.577	3.490
N° 8 (OFF)	3.516	3.592	3.566	3.544	3.539	3.465	3.195	3.525	3.533
N° 9 (OFF)	3.588	3.561	3.581	3.599	3.577	3.490	3.176	3.546	3.551
N° 10 (OFF)	3.528	3.520	3.543	3.547	3.540	3.455	3.207	3.580	3.579
N° 11 (OFF)	3.597	3.603	3.592	3.538	3.547	3.388	2.589	3.522	3.550

Delta [DV<sub>k2</sub>]

	0krad(Si)	25krad(Si)	50krad(Si)	75krad(Si)	100krad(Si)	200krad(Si)	300krad(Si)	24h/25°C	168h/100°C
N° 1 (Ref)	---	-4.159E-2	-4.068E-2	3.140E-3	-4.576E-2	-5.423E-2	-4.367E-2	-6.220E-2	-6.832E-2
N° 2 (Bias1)	---	3.022E-2	2.020E-2	7.970E-3	2.339E-2	3.765E+0	4.924E+0	-6.364E-2	7.306E-2
N° 3 (Bias1)	---	-1.483E-2	3.282E-2	-4.266E-2	-6.871E-2	3.612E+0	5.029E+0	-1.900E-2	-1.531E-2
N° 4 (Bias1)	---	-2.499E-2	2.710E-3	2.011E-2	1.015E-2	3.829E+0	4.283E+0	-2.081E-2	7.620E-3
N° 5 (Bias1)	---	-3.340E-3	2.521E-2	9.820E-3	2.362E-2	3.964E+0	5.223E+0	-1.150E-2	-1.923E-2
N° 6 (Bias1)	---	-1.104E-2	4.388E-2	2.780E-2	-2.100E-4	4.136E+0	4.593E+0	-1.780E-2	2.090E-2
N° 7 (OFF)	---	6.773E-2	2.705E-2	1.394E-2	1.458E-2	-2.276E-2	-1.101E-1	9.483E-2	8.030E-3
N° 8 (OFF)	---	7.590E-2	4.996E-2	2.857E-2	2.321E-2	-5.106E-2	-3.206E-1	8.960E-3	1.764E-2
N° 9 (OFF)	---	-2.706E-2	-6.930E-3	1.111E-2	-1.041E-2	-9.827E-2	-4.120E-1	-4.164E-2	-3.669E-2
N° 10 (OFF)	---	-7.210E-3	1.503E-2	1.950E-2	1.248E-2	-7.273E-2	-3.209E-1	5.280E-2	5.191E-2
N° 11 (OFF)	---	5.100E-3	-5.700E-3	-5.971E-2	-5.024E-2	-2.097E-1	-1.009E+0	-7.541E-2	-4.773E-2
Average (OFF)	---	-4.796E-3	2.496E-2	4.608E-3	-2.352E-3	3.861E+0	4.810E+0	-2.655E-2	1.341E-2
s (OFF)	---	2.107E-2	1.531E-2	2.762E-2	3.841E-2	1.990E-1	3.726E-1	2.103E-2	3.721E-2
Average+3s (OFF)	---	5.841E-2	7.089E-2	8.746E-2	1.129E-1	4.458E+0	5.928E+0	3.653E-2	1.250E-1
Average-3s (OFF)	---	-6.800E-2	-2.096E-2	-7.824E-2	-1.176E-1	3.264E+0	3.693E+0	-8.963E-2	-9.822E-2
Average (Bias1)	---	2.289E-2	1.588E-2	2.682E-3	-2.076E-3	-9.091E-2	-4.345E-1	7.908E-3	-1.368E-3
s (Bias1)	---	4.620E-2	2.384E-2	3.551E-2	2.966E-2	7.199E-2	3.397E-1	6.886E-2	4.088E-2
Average+3s (Bias1)	---	1.615E-1	8.739E-2	1.092E-1	8.689E-2	1.251E-1	5.846E-1	2.145E-1	1.213E-1
Average-3s (Bias1)	---	-1.157E-1	-5.563E-2	-1.038E-1	-9.104E-2	-3.069E-1	-1.454E+0	-1.987E-1	-1.240E-1

## 7. Rka

Ta=25°C ; DIk = 10µA to 10 mA



Rka . (Ohm) Max = 0.3

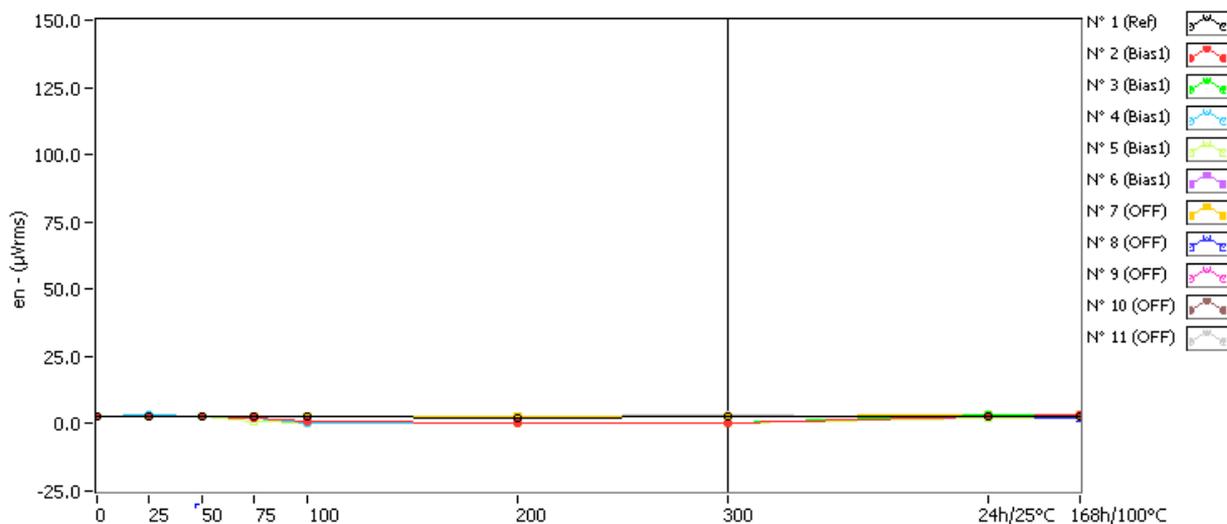
	0krad(Si)	25krad(Si)	50krad(Si)	75krad(Si)	100krad(Si)	200krad(Si)	300krad(Si)	24h/25°C	168h/100°C
N° 1 (Ref)	0.256	0.253	0.254	0.256	0.253	0.252	0.253	0.252	0.252
N° 2 (Bias1)	0.254	0.256	0.256	0.255	0.256	4.556	6.852	0.234	0.259
N° 3 (Bias1)	0.262	0.260	0.265	0.259	0.256	9.108	5.089	0.253	0.265
N° 4 (Bias1)	0.261	0.258	0.262	0.262	0.263	4.475	4.808	0.247	0.263
N° 5 (Bias1)	0.257	0.256	0.257	0.258	0.263	8.578	5.061	0.247	0.257
N° 6 (Bias1)	0.251	0.249	0.253	0.252	0.253	5.905	5.325	0.224	0.254
N° 7 (OFF)	0.252	0.258	0.257	0.256	0.257	0.245	0.076	0.257	0.253
N° 8 (OFF)	0.255	0.261	0.259	0.257	0.255	0.233	0.053	0.252	0.259
N° 9 (OFF)	0.259	0.258	0.259	0.259	0.260	0.231	0.025	0.260	0.260
N° 10 (OFF)	0.255	0.255	0.258	0.258	0.255	0.233	0.079	0.257	0.261
N° 11 (OFF)	0.260	0.261	0.261	0.257	0.260	0.203	0.171	0.254	0.258

Delta [Rka]

	0krad(Si)	25krad(Si)	50krad(Si)	75krad(Si)	100krad(Si)	200krad(Si)	300krad(Si)	24h/25°C	168h/100°C
N° 1 (Ref)	---	-2.754E-3	-2.448E-3	1.271E-4	-2.605E-3	-3.587E-3	-3.107E-3	-3.612E-3	-4.345E-3
N° 2 (Bias1)	---	1.237E-3	1.555E-3	8.208E-4	1.941E-3	4.302E+0	6.598E+0	-2.022E-2	4.962E-3
N° 3 (Bias1)	---	-1.507E-3	2.827E-3	-3.186E-3	-5.546E-3	8.846E+0	4.827E+0	-9.152E-3	2.654E-3
N° 4 (Bias1)	---	-2.146E-3	1.089E-3	1.903E-3	1.997E-3	4.215E+0	4.547E+0	-1.329E-2	2.248E-3
N° 5 (Bias1)	---	-4.685E-4	-4.425E-4	1.448E-3	6.153E-3	8.321E+0	4.804E+0	-1.026E-2	1.571E-4
N° 6 (Bias1)	---	-1.573E-3	1.835E-3	1.121E-3	2.270E-3	5.654E+0	5.074E+0	-2.684E-2	2.791E-3
N° 7 (OFF)	---	5.344E-3	4.725E-3	3.530E-3	4.344E-3	-6.972E-3	-1.759E-1	5.194E-3	1.212E-3
N° 8 (OFF)	---	5.912E-3	4.682E-3	2.647E-3	2.200E-5	-2.175E-2	-2.013E-1	-2.487E-3	4.219E-3
N° 9 (OFF)	---	-6.796E-4	1.392E-4	-4.524E-4	1.259E-3	-2.805E-2	-2.340E-1	6.367E-4	9.360E-4
N° 10 (OFF)	---	-2.242E-4	2.567E-3	2.513E-3	1.700E-5	-2.242E-2	-1.757E-1	2.236E-3	5.691E-3
N° 11 (OFF)	---	8.208E-4	4.975E-4	-2.781E-3	-4.875E-4	-5.654E-2	-8.868E-2	-5.783E-3	-1.572E-3
Average (OFF)	---	-8.915E-4	1.373E-3	4.214E-4	1.363E-3	6.268E+0	5.170E+0	-1.595E-2	2.562E-3
s (OFF)	---	1.335E-3	1.198E-3	2.056E-3	4.249E-3	2.198E+0	8.195E-1	7.459E-3	1.710E-3
Average+3s (OFF)	---	3.113E-3	4.965E-3	6.590E-3	1.411E-2	1.286E+1	7.629E+0	6.425E-3	7.694E-3
Average-3s (OFF)	---	-4.896E-3	-2.220E-3	-5.747E-3	-1.139E-2	-3.251E-1	2.711E+0	-3.833E-2	-2.569E-3
Average (Bias1)	---	2.235E-3	2.522E-3	1.091E-3	1.031E-3	-2.715E-2	-1.751E-1	-4.044E-5	2.097E-3
s (Bias1)	---	3.152E-3	2.196E-3	2.635E-3	1.961E-3	1.819E-2	5.390E-2	4.243E-3	2.873E-3
Average+3s (Bias1)	---	1.169E-2	9.111E-3	8.996E-3	6.914E-3	2.742E-2	-1.341E-2	1.269E-2	1.072E-2
Average-3s (Bias1)	---	-7.220E-3	-4.067E-3	-6.813E-3	-4.852E-3	-8.171E-2	-3.368E-1	-1.277E-2	-6.521E-3

## 8. en

Ta=25°C ; I<sub>k</sub> = 10 μA ; f = 1 kHz



en . (μVrms)	0krad(Si)	25krad(Si)	50krad(Si)	75krad(Si)	100krad(Si)	200krad(Si)	300krad(Si)	24h/25°C	168h/100°C
N° 1 (Ref)	2.565	2.421	2.421	2.449	2.506	2.366	2.449	2.979	2.686
N° 2 (Bias1)	2.449	2.686	2.625	1.968	0.723	0.141	0.144	2.780	3.623
N° 3 (Bias1)	2.625	2.625	2.717	1.858	0.637	0.088	0.148	3.084	2.812
N° 4 (Bias1)	2.945	3.048	2.945	2.133	0.555	0.117	0.107	2.945	2.911
N° 5 (Bias1)	2.449	2.478	2.506	1.120	0.251	0.112	0.190	2.109	2.655
N° 6 (Bias1)	2.594	2.506	2.449	2.037	0.456	0.069	0.077	2.286	2.748
N° 7 (OFF)	2.945	2.979	2.945	2.812	3.013	2.979	3.013	3.192	3.229
N° 8 (OFF)	2.535	2.625	2.506	2.449	2.655	2.625	2.845	2.625	2.312
N° 9 (OFF)	2.845	2.878	2.845	2.780	2.812	2.748	2.911	3.304	2.565
N° 10 (OFF)	2.594	2.535	2.478	2.506	2.506	2.625	2.655	2.394	2.339
N° 11 (OFF)	2.449	2.506	2.506	2.717	2.625	2.506	3.155	2.312	2.339

### Delta [en]

	0krad(Si)	25krad(Si)	50krad(Si)	75krad(Si)	100krad(Si)	200krad(Si)	300krad(Si)	24h/25°C	168h/100°C
N° 1 (Ref)	---	-1.435E-1	-1.435E-1	-1.154E-1	-5.838E-2	-1.986E-1	-1.154E-1	4.141E-1	1.209E-1
N° 2 (Bias1)	---	2.363E-1	1.752E-1	-4.812E-1	-1.726E+0	-2.308E+0	-2.305E+0	3.307E-1	1.174E+0
N° 3 (Bias1)	---	0.000E+0	9.223E-2	-7.665E-1	-1.988E+0	-2.537E+0	-2.477E+0	4.590E-1	1.877E-1
N° 4 (Bias1)	---	1.035E-1	0.000E+0	-8.115E-1	-2.390E+0	-2.828E+0	-2.838E+0	0.000E+0	-3.371E-2
N° 5 (Bias1)	---	2.836E-2	5.705E-2	-1.330E+0	-2.199E+0	-2.337E+0	-2.259E+0	-3.405E-1	2.056E-1
N° 6 (Bias1)	---	-8.808E-2	-1.451E-1	-5.572E-1	-2.138E+0	-2.525E+0	-2.517E+0	-3.086E-1	1.537E-1
N° 7 (OFF)	---	3.410E-2	0.000E+0	-1.325E-1	6.859E-2	3.410E-2	6.859E-2	2.471E-1	2.841E-1
N° 8 (OFF)	---	8.910E-2	-2.902E-2	-8.608E-2	1.195E-1	8.910E-2	3.094E-1	8.910E-2	-2.231E-1
N° 9 (OFF)	---	3.294E-2	0.000E+0	-6.476E-2	-3.256E-2	-9.658E-2	6.626E-2	4.593E-1	-2.800E-1
N° 10 (OFF)	---	-5.906E-2	-1.168E-1	-8.808E-2	-8.808E-2	3.004E-2	6.043E-2	-2.009E-1	-2.554E-1
N° 11 (OFF)	---	5.705E-2	5.705E-2	2.674E-1	1.752E-1	5.705E-2	7.060E-1	-1.370E-1	-1.102E-1
Average (OFF)	---	5.602E-2	3.587E-2	-7.892E-1	-2.088E+0	-2.507E+0	-2.479E+0	2.812E-2	3.374E-1
s (OFF)	---	1.219E-1	1.195E-1	3.324E-1	2.484E-1	2.075E-1	2.285E-1	3.631E-1	4.771E-1
Average+3s (OFF)	---	4.217E-1	3.942E-1	2.079E-1	-1.343E+0	-1.885E+0	-1.794E+0	1.117E+0	1.769E+0
Average-3s (OFF)	---	-3.096E-1	-3.225E-1	-1.786E+0	-2.833E+0	-3.129E+0	-3.165E+0	-1.061E+0	-1.094E+0
Average (Bias1)	---	3.083E-2	-1.775E-2	-2.081E-2	4.852E-2	2.274E-2	2.421E-1	9.153E-2	-1.169E-1
s (Bias1)	---	5.518E-2	6.356E-2	1.630E-1	1.081E-1	7.071E-2	2.801E-1	2.726E-1	2.334E-1
Average+3s (Bias1)	---	1.964E-1	1.729E-1	4.682E-1	3.727E-1	2.349E-1	1.082E+0	9.093E-1	5.833E-1
Average-3s (Bias1)	---	-1.347E-1	-2.084E-1	-5.098E-1	-2.757E-1	-1.894E-1	-5.981E-1	-7.262E-1	-8.171E-1